

<b>Notice of References Cited</b>	Application/Control No. 09/786,878	Applicant(s)/Patent Under Reexamination DEWA, YOSHIHARU	
	Examiner Shabana Qureshi	Art Unit 2155	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0108101	08-2002	Charisius et al.	717/105
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